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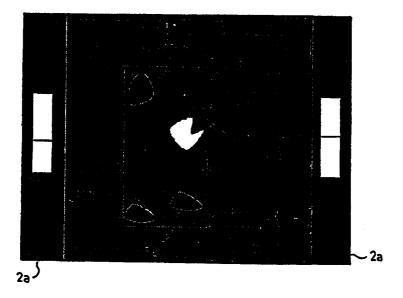
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(54) Title: METHOD FOR DETECTING IMPERFECTIONS ON A SURFACE INSPECTED



## (57) Abstract

The invention relates to a method for detecting imperfections on a surface inspected. The method comprises the steps of providing and segmenting image information to form blobs (BL1-BL4); feature extraction for the blobs; clustering of the blobs, in which the image blobs are grouped into several clusters (A, B), each of which contains one or more blobs (BL1-BL4). The clustering is continued by further grouping the clusters (A, B) to form one or more higher-level clusters (AB) comprising lower-level clusters (A, B); and the method also comprises classification in which clusters are compared with imperfection prototypes and one or more clusters are defined that achieve sufficient classification certainty in relation to an imperfection prototype. In the invention, the clusters formed (A, B) are subjected to feature extraction, and the classification is conducted such that in addition to lower-level clusters (A, B), a higher-level cluster (AB) comprising these lower-level clusters (A, B) is compared with the imperfection prototypes.

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#### INTERNATIONAL SEARCH REPORT

International application No. PCT/FI 95/00469

## A. CLASSIFICATION OF SUBJECT MATTER

IPC6: G06K 9/62 // G01N 21/89
According to International Patent Classification (IPC) or to both national classification and IPC

## **B. FIELDS SEARCHED**

Minimum documentation searched (classification system followed by classification symbols)

IPC6: G06K, G01N

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

SE,DK,FI,NO classes as above

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Y	EP 0048568 A2 (TRW INCORPORATED), 31 March 1982 (31.03.82), page 10, line 15 - line 28, figure 1	1
Y	EP 0093422 A2 (HONEYWELL INC.), 9 November 1983 (09.11.83), page 4, line 13 - line 23, figure 1	1
A	GB 2270227 A (SURFACE INSEPCTION LIMITED), 2 March 1994 (02.03.94), figure 1, abstract	1-12
A	US 5274713 A (HC. CHANG ET AL), 28 December 1993 (28.12.93), column 5, line 6 - line 12, figure 2	1-12

X	Further documents are listed in the continuation of Box	C.	X See patent family annex.		
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	Date of the actual completion of the international search  27 February 1996		Date of mailing of the international search report  27 -02- 1396		
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International application No.
PCT/FI 95/00469

Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No
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Information on patent family members

05/02/96

International application No.
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